

UNITED STATES PATENT APPLICATION

of

Clifford I. Drowley

and

Ching-Chun Wang

for

**MICROLENS FOR USE WITH A SOLID-STATE IMAGE SENSOR AND
A NON-TELECENTRIC TAKING LENS**

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AND A NON-TELECENTRIC TAKING LENS**

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PRIORITY INFORMATION

This application claims priority from US Provisional Patent Application, Serial Number 60/417,982, filed on October 11, 2002. The entire contents of US Provisional Patent Application, Serial Number 60/417,982 are hereby incorporated by reference.

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FIELD OF THE PRESENT INVENTION

The present invention relates generally to image sensing technology. More specifically, the present invention relates to a CMOS image sensor that uses shifted microlenses, color filter areas, and apertures to increase the light collection efficiency of a photosensor or photodiode as well as decreasing color signal crosstalk between adjacent pixels.

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BACKGROUND OF THE PRESENT INVENTION

Conventionally, imaging technology has been centered around charge coupled device (CCD) image sensors. However, recently, CMOS imaging technology has become increasingly the technology of choice. There are a variety of reasons for this progression.

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First, CCD imagers require specialized facilities, which are dedicated exclusively to the fabrication of CCDs. Second, CCD imagers consume a substantial amount of power, since they are essentially capacitive devices, which require external control signals and large clock swings to achieve acceptable charge transfer efficiencies. Third, CCD imagers require several support chips to operate the device, condition the image signal, perform post processing, and generate standard video output. This need for additional support circuitry makes CCD systems complex. Finally, CCD systems require numerous power supplies, clock drivers and voltage regulators, which not only further increase the complexity of the design, but also demand the consumption of additional significant amounts of power.

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By contrast, CMOS imagers are characterized by a less complex design. The more simple architecture translates into a reduction in engineering and production costs and a concomitant and substantial reduction in power consumption. With today's sub-micron CMOS fabrication processes, CMOS imagers have also become highly integrated. For example, an entire CMOS-based imaging system, such as a digital camera, can be fabricated on a single semiconductor chip. Additionally, unlike CCD imagers, CMOS imagers are amenable to fabrication in standard CMOS fabrication facilities. This adaptability significantly reduces plant over-head costs. For these reasons, CMOS imagers are swiftly becoming the imagers of choice.

An image sensor is comprised of an array of picture elements or "pixels," wherein each pixel comprises a photodiode or photosensor. A layout for an exemplary CMOS unit pixel 10 is shown in Figure 1. Unit pixel 10 is comprised of a rectangular image sensing area 100, transfer transistor 102, floating node 104, reset transistor 106, drive transistor 108, select transistor 110, and output 112. Unit pixel 10 is powered by power supply VDD 114. Image sensing area 100 is made rectangular to maximize the "fill factor," which is defined as the percentage of the unit pixel 10 area occupied by image sensing area 100. A typical fill factor for the arrangement of Figure 1 is approximately 30%.

Referring now to Figure 2, there is shown a plan view of a partial array of pixels 20, according to conventional CMOS image sensor devices. By positioning cylindrically shaped microlenses 203 over image sensing areas 200, the effective fill factor for the layout of Figure 1 can be improved, as incident light 204 is focused more towards the center of rectangular image sensing areas 200 by microlenses 203. The percentage of each unit pixel 20 occupied by each image sensing area 200 does not, of course, change by employment of microlenses 203. Nevertheless, light capture is improved and the effective fill factor is increased. Use of cylindrically shaped microlenses 203 can increase the effective fill factor to approximately 75%.

Despite the improvement in effective fill factor using cylindrically shaped microlenses, there are negative performance factors, which are attributable to use of rectangular-shaped image sensing areas and cylindrically- shaped microlenses.

First, referring to Figure 2, whereas utilization of cylindrically shaped microlenses 203 is effective at directing incident light 204 arriving at angles perpendicular to the major axes (major axes are in x-direction) of the lenses 203, the cylindrically shaped microlenses 203 are not very effective at focusing incident light 204 arriving at angles non-perpendicular to, i.e. oblique to, the major axes of the cylindrically shaped microlenses 203. This ineffectiveness further involves light that is scattered and/or reflected and which ultimately arrives at the lenses 203 at oblique angles.

The ineffectiveness of cylindrically shaped microlenses 203 to focus incident light towards the center of the image sensing areas 200 is problematic due to the fact that neighboring rectangular-shaped image sensing areas are in close proximity in the x-direction, where the horizontal spacing between neighboring pixels is shown to be approximately 0.8 μm . The close proximity results in random diffusion of photocharge generated outside the photodiode depletion regions. Photocharge that is generated outside the depletion region of a particular pixel is prone to capture by a neighboring pixel. When photocharge is unwanted captured by an adjacent pixel, electrical crosstalk occurs resulting in a reduction in image sharpness.

There is another type of crosstalk that can be attributed to the close proximity of neighboring rectangular-shaped image sensing areas 200. This second type of crosstalk occurs between pixels of different colors and is referred to in the art as "color crosstalk." Color crosstalk leads to color distortion and is largely caused by the fact that silicon-based photodiodes have a wavelength-dependent photon absorption response.

In particular, color distortion can be significant for image arrays that use rectangular-shaped image sensing areas together with an RGB Bayer pattern color filter. In fact, a difference on the order of 10% in the response of G_R , (green pixels adjacent to red pixels in the same row) and G_B , (green pixels adjacent to blue pixels in the same row), under uniform illumination, is observed when rectangular-shaped image sensing areas are used. This difference in green pixel responsivity results in color distortion.

Finally, yet another problem that is observed when neighboring image-sensing areas are too closely positioned, is a decrease in spatial resolution. In imaging systems, resolution is quantified in terms of a modulation transfer function (MTF). The lower the

MTF, the less capable an imaging device is at picking up the fine detail and contrast in the object that is being imaged.

In furtherance of the above discussion, a digital imaging system for photographic, video, or other imaging applications generally includes two major components, a solid-state imaging device and a taking lens. Solid-state imaging devices, such as charge-coupled devices or CMOS image sensors, are typically constructed as two-dimensional arrays of photo-sensing elements, i.e., pixels. In an example CMOS image sensor, each CMOS pixel usually contains a photodiode as the sensing element, and this sensing element is typically embedded in a circuit with several MOS transistors. The other important part of the imaging system is taking lens. A taking lens is typically constructed of a multi-element glass, plastics, or glass-plastic hybrid lens assembly and generally employed in front of the imaging device to focus the light onto the sensor array.

The performance of an imaging system strongly depends on the light collection efficiency of the sensor. For the aforementioned example CMOS image sensor, the light collection efficiency is determined by the ratio of the photodiode area to the total pixel area, called "fill factor." A large fill factor is generally desired to increase the optical energy incident on the pixel that can be collected by the photodiode. However, the maximum achievable fill factor is limited by the CMOS fabrication design rules between photodiodes and MOS transistors. An example of this is illustrated in Figure 3.

As illustrated in Figure 3, an area of silicon **30** corresponding to a pixel area or site contains a photodiode **35**. This pixel site or area is usually covered by a dielectric **40**. Incident light **50** from an image to be captured passes through the dielectric layer **40** and impinges upon the area of silicon **30** containing the photodiode **35**. As further illustrated, not all of the incident light **50** impinges upon the photodiode **35**, thus the ratio of incident light **50** to that light which impinges upon the photodiode **35** is the light collection efficiency.

As the pixel size (**300 & 400**) is scaled down, as illustrated in Figure 4, to reduce the die size or increase the sensor resolution with a fixed die size in order to achieve some financial benefits, the area of the photodiode **350** needs to be shrunk further in accordance to the layout design rules. As a result, the fill factor is reduced and the sensor performance is degraded.

In order to compensate for the degraded light collection efficiency for small fill-factor pixels, a microlens **60**, as illustrated in Figure 5, has conventionally been placed over a pixel (**300** & **400**) to refract light hitting on the surface of the pixel (**400**) into the photodiode **350**. As shown in Figure 5, the microlens **60** concentrates light **500** from the taking lens onto the photodiode **350**, improving light collection efficiency and increasing the effective fill factor.

The effectiveness of the microlens **60** is influenced by the telecentricity of the taking lens. For slim cameras with thin lens assemblies, the taking lens **90** tends to be non-telecentric, as illustrated in Figure 7. That means the light rays **85** will impinge on the sensors **70** with a large incident angle. On the other hand, using a telecentric lens **80**, as illustrated in Figure 6, the light rays **82** impinge on the sensors **70** with a small incident angle. The angle is typically measured using chief rays, as shown in Figures 6 and 7. In typical lens considered for 1/3" SXGA sensor applications, the chief ray angle is 12°–23°.

The effect of a large chief ray angle, as illustrated in Figure 7, on an array with microlenses is significant. The incident angle causes the focus spot to shift away from the photodiode site as a function of pixel distance from the optical center of the array. This phenomenon is demonstrated in Figures 8 and 9.

As illustrated in Figure 8, incident light **550** from a telecentric lens impinges upon a microlens **60** that focuses the light through a dielectric layer **40** onto a pixel site **30** in which a photodiode **35** is located. Since the angle of the incident light **550**, as illustrated in Figure 8, is small, the light collection efficiency is high. On the other hand, in Figure 9, when using a non-telecentric lens, the incident light **560** impinges upon a microlens **60** that focuses the light through a dielectric layer **40** onto a pixel site **30** in which a photodiode **35** is located. As illustrated in Figure 9, since the angle of the incident light **560** is large relative to Figure 8, the microlens **60** shifts the focused light to a corner of the pixel site **30** so that the light collection efficiency is significantly reduced.

Therefore, it is desirable to provide an imager in which a non-telecentric lens can be used without reducing the light collection efficiency of the pixel site.

SUMMARY OF THE PRESENT INVENTION

5 A first aspect of the present invention is an imager. The imager includes a two-dimensional array of photosensors, each photosensor having a center point and a two-dimensional array of microlenses positioned over the two-dimensional array of photosensors, each microlens being associated with a corresponding photosensor, each microlens having a center point. The microlens is positioned over the corresponding photosensor such that a center point of a microlens is offset, in a first direction, from a center point of a corresponding photosensor.

10 A second aspect of the present invention is an imager. The imager includes a two-dimensional array of photosensors, each photosensor having a center point and a color filter array positioned over the two-dimensional array of photosensors, the color filter array including a plurality of color filter areas, each color filter area being associated with a corresponding photosensor and having a center point. The color filter area is positioned over a corresponding photosensor such that a center point of a color filter area is offset, in a first direction, from a center point of a corresponding photosensor.

15 A third aspect of the present invention is an imager. The imager includes a two-dimensional array of photosensors, each photosensor having a center point and a layer of transmissive apertures positioned over the two-dimensional array of photosensors, each aperture being associated with a corresponding photosensor and having a center point. The aperture is positioned over the corresponding photosensor such that a center point of a aperture is offset, in a first direction, from a center point of a corresponding photosensor.

A fourth aspect of the present invention is an imager. The imager includes a two-dimensional array of photosensors, each photosensor having a center point; a two-dimensional array of microlenses positioned over the two-dimensional array of photosensors, each microlens being associated with a corresponding photosensor, each microlens having a center point; a color filter array positioned over the two-dimensional array of photosensors, the color filter array including a plurality of color filter areas, each color filter area being associated with a corresponding photosensor and having a center point; and a layer of transmissive apertures positioned over the two-dimensional array of photosensors, each aperture being associated with a corresponding photosensor and having a center point. The microlens is positioned over the corresponding photosensor such that a center point of a microlens is offset, in a first direction, from a center point of a corresponding photosensor. The color filter area is positioned over the corresponding photosensor such that a center point of a color filter area is offset, in the first direction, from a center point of a corresponding photosensor. The aperture is positioned over the corresponding photosensor such that a center point of an aperture is offset, in the first direction, from a center point of the corresponding photosensor.

A fifth aspect of the present invention is an imaging system. The imaging system includes a two-dimensional array of photosensors, each photosensor having a center point; a non-telecentric lens positioned over the two-dimensional array of photosensors; and a two-dimensional array of microlenses positioned over the two-dimensional array of photosensors, each microlens being associated with a corresponding photosensor, each microlens having a center point. The microlens is positioned over the corresponding photosensor such that a center point of a microlens is offset from a center point of a corresponding photosensor, each offset having an amount and a direction such that the amounts and directions spatially vary across the two-dimensional array of photosensors. The spatial variation is determined based on optical characteristics of the non-telecentric lens and optical properties of the two-dimensional array of photosensors and the microlenses such that light sensitivity of each pixel is maximized.

A sixth aspect of the present invention is an imaging system. The imaging system includes a two-dimensional array of photosensors, each photosensor having a center point; a non-telecentric lens positioned over the two-dimensional array of photosensors; and a color filter array positioned over the two-dimensional array of photosensors, the color filter array including a plurality of color filter areas, each color filter area being associated with a corresponding photosensor and having a center point. The color filter area is positioned over the corresponding photosensor such that the center point of the color filter area is offset from the center point of the corresponding photosensor, each offset having an amount and a direction such that the amounts and directions spatially vary across the two-dimensional array of photosensors. The spatial variation is determined based on optical characteristics of the non-telecentric lens and optical properties of the two-dimensional array of photosensors and the color filter areas such that crosstalk is minimized.

A seventh aspect of the present invention is an imaging system. The imaging system includes a two-dimensional array of photosensors, each photosensor having a center point; a non-telecentric lens positioned over the two-dimensional array of photosensors; and a layer of transmissive apertures positioned over the two-dimensional array of photosensors, each aperture being associated with a corresponding photosensor and having a center point. The aperture is positioned over the corresponding photosensor such that the center point of the aperture is offset from the center point of the corresponding photosensor, each offset having an amount and a direction such that the amounts and directions spatially vary across the two-dimensional array of photosensors. The spatial variation is determined based on optical characteristics of the non-telecentric lens and optical properties of the two-dimensional array of photosensors and the apertures such that stray light signals are minimized.

Another aspect of the present invention is an imaging system. The imaging system includes a two-dimensional array of photosensors, each photosensor having a center point; a non-telecentric lens positioned over the two-dimensional array of photosensors; a two-dimensional array of microlenses positioned over the two-dimensional array of photosensors, each microlens being associated with a corresponding

photosensor, each microlens having a center point; a color filter array positioned over the two-dimensional array of photosensors, the color filter array including a plurality of color filter areas, each color filter area being associated with a corresponding photosensor and having a center point; and a layer of transmissive apertures positioned over the two-dimensional array of photosensors, each aperture being associated with a corresponding photosensor and having a center point. The microlens is positioned over the corresponding photosensor such that the center point of the microlens is offset from the center point of the corresponding photosensor, each microlens offset having an amount and a direction such that the amounts and directions spatially vary across the two-dimensional array of photosensors. The color filter area is positioned over the corresponding photosensor such that the center point of the color filter area is offset from the center point of the corresponding photosensor, each color filter area offset having an amount and a direction such that the amounts and directions spatially vary across the two-dimensional array of photosensors. The aperture is positioned over the corresponding photosensor such that the center point of the aperture is offset, in the first direction, from the center point of the corresponding photosensor, each aperture offset having an amount and a direction such that the amounts and directions spatially vary across the two-dimensional array of photosensors. The spatial variation of the microlens offsets is determined based on optical characteristics of the non-telecentric lens and optical properties of the two-dimensional array of photosensors and the microlenses such that light sensitivity of each pixel is maximized. The spatial variation of the color filter area offsets is determined based on optical characteristics of the non-telecentric lens and optical properties of the two-dimensional array of photosensors and the color filter areas such that crosstalk is minimized. The spatial variation of the aperture offsets is determined based on optical characteristics of the non-telecentric lens and optical properties of the two-dimensional array of photosensors and the apertures such that stray light signals are minimized.

BRIEF DESCRIPTION OF THE DRAWINGS

The present invention may take form in various components and arrangements of components, and in various steps and arrangements of steps. The drawings are only for purposes of illustrating a preferred embodiment and are not to be construed as limiting the present invention, wherein:

Figure 1 is a layout view of a unit pixel for a typical CMOS image sensor;

Figure 2 illustrates a partial array of pixels employing cylindrically shaped microlenses over image sensing areas;

Figure 3 graphically illustrates light collection efficiency of a pixel;

Figure 4 graphically illustrates light collection efficiency of a scaled down pixel;

Figure 5 graphically illustrates light collection efficiency of a scaled down pixel with a microlens position above it;

Figure 6 illustrates small chief ray angles for telecentric lens;

Figure 7 illustrates large chief ray angles for non-telecentric lens;

Figure 8 graphically illustrates light collection efficiency of an imager with telecentric lens;

Figure 9 graphically illustrates light collection efficiency of an imager with non-telecentric lens;

Figure 10 graphically illustrates another example of light collection efficiency of an imager with non-telecentric lens, a non-shifted microlens, and a non-shifted color filter array layer;

Figure 11 graphically illustrates an example of light collection efficiency of an imager with non-telecentric lens and a non-shifted color filter array layer with a shifted microlens according to the concepts of the present invention;

Figure 12 graphically illustrates an example of light collection efficiency of an imager with non-telecentric lens with a shifted color filter array layer and shifted microlens according to the concepts of the present invention;

Figure 13 illustrates a top view of a pixel site with a microlens;

Figure 14 graphically illustrates light collection of unfocused light;

Figure 15 illustrates an imager with a microlens, color filter array, and aperture layer;

Figure 16 illustrates an imager with a shifted microlens, a shifted color filter array, and a shifted aperture layer according to the concepts of the present invention;

Figure 17 graphically illustrates simulation results of microlens offset versus pixel location;

Figure 18 graphically illustrates a top view of an imager with a shifted microlens, a shifted color filter array, and a shifted aperture layer according to the concepts of the present invention; and

Figure 19 illustrates an imager with a shifted microlens that varies in a radial pattern relative to the optical axis of the lens.

DETAILED DESCRIPTION OF THE PRESENT INVENTION

The present invention will be described in connection with preferred embodiments; however, it will be understood that there is no intent to limit the present invention to the embodiments described herein. On the contrary, the intent is to cover all alternatives, modifications, and equivalents as may be included within the spirit and scope of the present invention as defined by the appended claims.

For a general understanding of the present invention, reference is made to the drawings. In the drawings, like reference have been used throughout to designate identical or equivalent elements. It is also noted that the various drawings illustrating the present invention are not drawn to scale and that certain regions have been purposely drawn disproportionately so that the features and concepts of the present invention could be properly illustrated.

As noted above, when using a non-telecentric lens, the incident light encounters the pixel site at large angles, which can adversely affect the light collection efficiency. As illustrated in Figure 10, an example of an imager using a non-telecentric lens is shown. Light 560, from a non-telecentric lens (not shown) impinges upon a microlens 60 that focuses the light through a dielectric layer 410 and a color filter array layer having color filter areas 420, 430, and 440. Upon leaving color filter array layer, the light passes through another dielectric layer before being incident upon a pixel site 30 in which a

photodiode 35 is located. As illustrated in Figure 10, since the angle of the incident light 560 is large, the microlens 60 shifts the focused light to a corner of the pixel site 30 so that the light collection efficiency is significantly reduced. It noted that in the example of Figure 10, the pixel site 30 has a center point or center line 375, and the microlens 60 has a center point or center line 605. These center lines 375 and 605 are lined up so that there is no physical offset between them.

In order to compensate for the lens spot shift, in accordance with the present invention, the microlens is shifted in the opposite direction in order to bring the focus spot back onto the photodiode. This shift is illustrated in Figure 11.

As illustrated in Figure 11, light 560, from a non-telecentric lens (not shown) impinges upon a shifted or offset microlens 60 that focuses the light through a dielectric layer 410 and a color filter array layer having color filter areas 420, 430, and 440. Upon leaving color filter array layer, the light passes through another dielectric layer before being incident upon a pixel site 30 in which a photodiode 35 is located. It noted that in the example of Figure 11, the pixel site 30 has a center point or center line 375, and the microlens 60 has a center point or center line 605. Since the microlens 60 has been shifted, the center lines 375 and 605 no longer coincide as in Figure 10, but there is a physical offset between them. This offset allows the shifted microlens 60, to shift more of the focused light onto the photodiode 35. Thus, although the angle of the incident light 560 is large, the shifted microlens 60 shifts more of the focused light to the photodiode 35 of the pixel site 30 so that the light collection efficiency is significantly increased.

However, when color filters are employed, as illustrated in Figure 11, with an image sensor to enable production of a color image, it is preferred in accordance with the present invention that in addition to shifting of microlenses, the color filters underlying the microlens also be shifted, particularly for large chief-ray angles. If the color filter array (CFA) is not properly shifted, as shown in Figure 11, it is possible that some light collected from a shifted microlens 60 could pass through an unintended color filter. By shifting the color filters relative, as illustrated in Figure 12, to the array in the manner of the microlens, proportional to the filter optical height relative to the lens optical height, any color mixing effects due to unintended direction of incident light can be avoided.

As illustrated in Figure 12, light 560, from a non-telecentric lens (not shown) impinges upon a shifted or offset microlens 60 that focuses the light through a dielectric layer 410 and a shifted color filter array layer having shifted color filter areas 420, 430, and 440. Upon leaving the shifted color filter array layer, the light passes through another dielectric layer before being incident upon a pixel site 30 in which a photodiode 35 is located. It is noted that in the example of Figure 12, the pixel site 30 has a center point or center line 375, the microlens 60 has a center point or center line 605, and the color filter area 430 associated with the photodiode 35 has a center point or center line 435.

Since the microlens 60 has been shifted, the center points 375 and 605 no longer line up as in Figure 10, but there is a physical offset between them. Moreover, since the color filter area 430 of the color filter array has been shifted, the center points 375 and 435 no longer line up as in Figures 10 and 11, but there is a physical offset between them. These offsets allow the shifted microlens 60, to shift more of the focused light onto the photodiode 35 and the shifted color filter area 430 to filter the light without having the light pass through an unintended color filter. Thus, although the angle of the incident light 560 is large, the shifted microlens 60 shifts more of the focused light to the photodiode 35 of the pixel site 30 and the shifted color filter area 430 filters the light without having the light pass through an unintended color filter so that the light collection efficiency is significantly increased.

Although the microlens and color filter shifting techniques described above are effective to some degree, they do not compensate for scattered incident light. This light scattering comes about due to the fact that the efficiency of a microlens is not 100%. The formation process for the lens typically results in a circular lens, while pixels are typically square. This geometric relationship results in nearly 25% of the pixel area not being covered by the microlens, as shown in Figure 13, wherein the microlens 610 includes unfocused regions 620. As a consequence, some fraction of the incident light is not focused by the microlens 610, and this unfocused, or stray, light passes instead through whatever photodiode happens to be in the trajectory of the light. When the microlens is shifted, this stray light can tend to impinge on the wrong pixel, resulting in optical crosstalk and color mixing between pixels. An example of this stray light

impinging upon the wrong pixel, resulting in optical crosstalk and color mixing between pixels, is illustrated in Figure 14.

As illustrated in Figure 14, light passes through shifted microlens **600**, dielectric layers **410** and shifted color filter areas **450**, **460**, and **470** before impinging upon photodiode **35** located in pixel site **30**. However, light can bypass the microlens **600** and thus be unfocussed upon the proper pixel site. In such a situation, as illustrated in Figure 14, the stray light may improperly be filtered by shifted color filter area **460** and impinge upon photodiode **351** in pixel site **301**. It noted that shifted color filter area **470** is associated with photodiode **351** in pixel site **301**, not shifted color filter area **460**. As a result of this improper filtering, optical crosstalk and color mixing between pixels occurs.

The present invention overcomes this stray light condition to enable effective non-telecentric lens compensation with shifted microlenses whose geometry is not identical to that of the pixel, while at the same time compensating for stray incident light. In this compensation technique, an opaque, e.g., metal, aperture under the microlens is shifted. This aperture can be provided as the top-level metal layer of a CMOS image sensor process, or other suitable, preferably opaque, layer. The aperture layer is arranged in such a way that the light from the microlens passes through the aperture, but unfocussed light incident around the aperture that can cause color mixing is blocked, as shown in Figure 16. As a result, the shifted metal or other aperture layer blocks a significant part of the light that does not pass through the microlens. This minimizes crosstalk. As a result, unfocussed light is substantially prevented from reaching an unintended pixel, and color mixing is prevented.

Figure 15 illustrates a typical imager structure that includes a non-shifted microlens **60**, a spacer **412**, a non-shifted color filter array layer **480**, a planar layer **413**, and a passivation layer **414**. Below the passivation layer **414**, there is an aperture layer consisting of a layer of metal aperture **95** and the other metal layers **97** and **99** below it are for signal routing. The height of the metal aperture layer, between the pixel site **30** and the passivation layer **414**, is H_{M3} . The distance between the pixel site **30** and the microlens **60** is H_{ML} . In this typical structure, as noted above, the non-shifted aperture layer fails to block a significant part of the light that does not pass through the microlens

as the chief ray angle is large. This causes crosstalk. As a result, unfocussed light is reaches an unintended pixel, and color mixing occurs.

Figure 16 provides an embodiment, according to the concepts of the present invention, that includes shifted metal or other aperture layer which blocks a significant part of the light that does not pass through the microlens. This minimizes crosstalk. As a result, unfocussed light is substantially prevented from reaching an unintended pixel, and color mixing is prevented.

As illustrated in Figure 16, an imager includes a shifted microlens **600** and a spacer **412**. The imager also includes a shifted color filter array layer **480**. In this embodiment, the aperture layer **950** is shifted so as to block a significant part of the light that does not pass through the shifted microlens **600**. In a preferred embodiment of the present invention, this aperture layer **950** is a metal aperture layer.

According to a preferred embodiment of the present invention, the metal shift geometry is derived from a corresponding lens shift as a metal shift distance that is proportional to the ratio of the metal layer height above the silicon substrate to the microlens height. Thus, if the metal level is height H_{M3} , as illustrated in Figure 15, above the silicon surface, and the microlens is height H_{ML} above the silicon surface, the shift of the metal pattern can be calculated as $\Delta M_3 = \frac{H_{M3}}{H_{ML}} \cdot \Delta ML$, where ΔML is the microlens

shift. In this case, the metal layer is assumed to be the top metal, but this relation applies to any metal or other layer being employed as the aperture/shield. An example shift is illustrated from a top-down view in Figure 18. In Figure 18, the microlens array **675** is shifted or offset from the pixel site array **678**. Moreover, the color filter array layer **676** and the aperture layer **677** are shifted or offset from the pixel site array **678**. It is noted that no shift is preferred at the center of the pixel array.

It is noted that the chief ray angle of a non-telecentric lens may vary across the focal surface of the lens as a function of distance from the optical axis of the lens. To address this property of non-telecentric lens, one embodiment of the present invention varies the offset of each microlens spatially across the photosensor array relative to the associated photosensor such that the offset is a radial pattern relative to the optical axis of the lens. This embodiment of the present invention is illustrated in Figure 19.

As illustrated in Figure 19, photosensors **900** are arranged in an array **910**. The associated microlenses **920** are also arranged in an array **930**. Each microlens is offset from the associated photosensor by a distance **940** that varies according to the chief ray angle variation of the non-telecentric lens (not shown) as a function of radial distance from the optical axis. The optical axis coincides with the photosensor array **910** at a central point **950**. It should be noted that the central point **950** in general may not coincide with the center point of a microlens or the center point of a photosensor.

It is recognized that microlens shapes can impact the degree of resulting stray light that is to be prevented. For example, an octagon-shaped microlens is understood to perform better than a square shape microlens, in terms of pixel-to-pixel crosstalk. This is because in lens fabrication, the patterning of an octagon-shaped microlens produces a circular-shaped lens after lens material reflow. The curvature is the same from all directions at any surface point. However, for a square-shaped microlens, the curvature is different along diagonal directions and horizontal/vertical directions. This deviation in curvature could result in differing refractive angles for light rays that are incident from different orientations, resulting in a higher degree of pixel-to-pixel crosstalk.

As described above, the present invention enables highly precise incident light focussing on an image sensor in a manner that inhibits pixel-to-pixel cross talk and color mixing. In accordance with the present invention, a microlens is shifted for better light collection efficiency when a non-telecentric taking lens is used. Further in accordance with the present invention, if an underlying color filter is employed with an imager, the color filter mosaic is also shifted to avoid color mixing. In addition, to further improve the performance, it is preferred in accordance with the present invention to utilize a shifted aperture layer, e.g., a metal layer with shifted apertures, to reduce crosstalk due to a scattering effect that results from light impinging substrate gaps between microlenses. An octagon-shaped microlens, rather than a square-shaped one, can be preferred to minimize crosstalk performance for its uniform curvature at the microlens surface.

In accordance with the present invention, any suitable technique can be employed to determine a shifting geometry. In one example, the CODE V optical simulation tool is utilized to calculate an optimized microlens shift. Before the simulation process is carried out, there are some critical parameters needed to construct the simulation

condition. The parameters include microlens curvature, microlens height and size, and thickness and refractive index of each dielectric layer. The back focal length, lens aperture or f/stop , and chief ray angle characteristics versus image radius of the utilized non-telecentric lens are also required in the simulation.

5 The simulation is based on ray tracing principle. When a directional light ray hits an interface of two dielectric layers, the ray will be refracted and will therefore proceed with a different angle. The angle at which the ray continues depends on the wavelength of the light rays, the curvature of the interface, and the refractive index of the dielectric layers at both sides of the junction. The angles are quantitatively governed by Snell's
10 law: $n_1 \cdot \sin(\theta_1) = n_2 \cdot \sin(\theta_2)$, where θ_1 and θ_2 are incident angle and refractive angle; n_1 and n_2 are refractive index of the dielectric layers. By calculating a large quantity of rays entering the optical system with various angles and locations, the performance of the system can be thus evaluated.

15 In the process of microlens shift optimization, the light rays that are initially focused by the taking lens onto the sensor surface will be re-focused by the microlens. It is noted that the re-focused rays will only be collected if the sensor is spatially offset from the microlens. From layout and silicon fabrication processing considerations, it is found that performing a microlens layout offset can be much easier than sensor layout offset. According to simulation results, the optimized offset quantity can be estimated by
20 the locations at which chief rays, i.e., rays passing through the center of an entrance pupil and the center of the microlens, hit the silicon surface. Figure 17 illustrates simulation results for microlens offset versus pixel location, for a situation where the chief ray angle varies linearly with distance on the focal plane from the optical axis. As shown in Figure 17, a linear relation between pixel location and microlens offset is a good approximation.
25 Such a linear relationship may not hold in all cases, e.g., where the chief ray angle variation is not a linear function of the distance from the optical axis on the focal plane.

30 In summary, the present invention includes a two-dimensional array of photosensors wherein each photosensor has a center point. The preferred embodiment of the present invention uses a non-telecentric lens that is positioned over the two-dimensional array of photosensors. A two-dimensional array of shifted microlenses is positioned over the two-dimensional array of photosensors. Each microlens is associated

with a corresponding photosensor such that the center point of the microlens is offset from the center point of the corresponding photosensor. The offset may be uni-directional or two-dimensional. A shifted color filter array is positioned over the two-dimensional array of photosensors wherein the color filter array includes a plurality of color filter areas, each color filter area being associated with a corresponding photosensor. The color filter area is positioned over the corresponding photosensor such that the center point of the color filter area is offset from the center point of the corresponding photosensor. The offset may be uni-directional or two-dimensional. Lastly, a layer of shifted transmissive apertures is positioned over the two-dimensional array of photosensors, each aperture being associated with a corresponding photosensor and having a center point. The aperture is positioned over the corresponding photosensor such that the center point of the aperture is offset from the center point of the corresponding photosensor. The offset may be uni-directional or two-dimensional.

While various examples and embodiments of the present invention have been shown and described, it will be appreciated by those skilled in the art that the spirit and scope of the present invention are not limited to the specific description and drawings herein, but extend to various modifications and changes.